

Search Notes

Application/Control No.

10/716,672

Examiner

Dah-Wei D. Yuan

Applicant(s)/Patent under
Reexamination

HARADA ET AL.

Art Unit

1745

SEARCHED

Class	Subclass	Date	Examiner
429	128	3/22/2007	DWY
429	137	3/22/2007	DWY
429	212	3/22/2007	DWY

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/22/2007	DWY
STN	3/22/2007	DWY